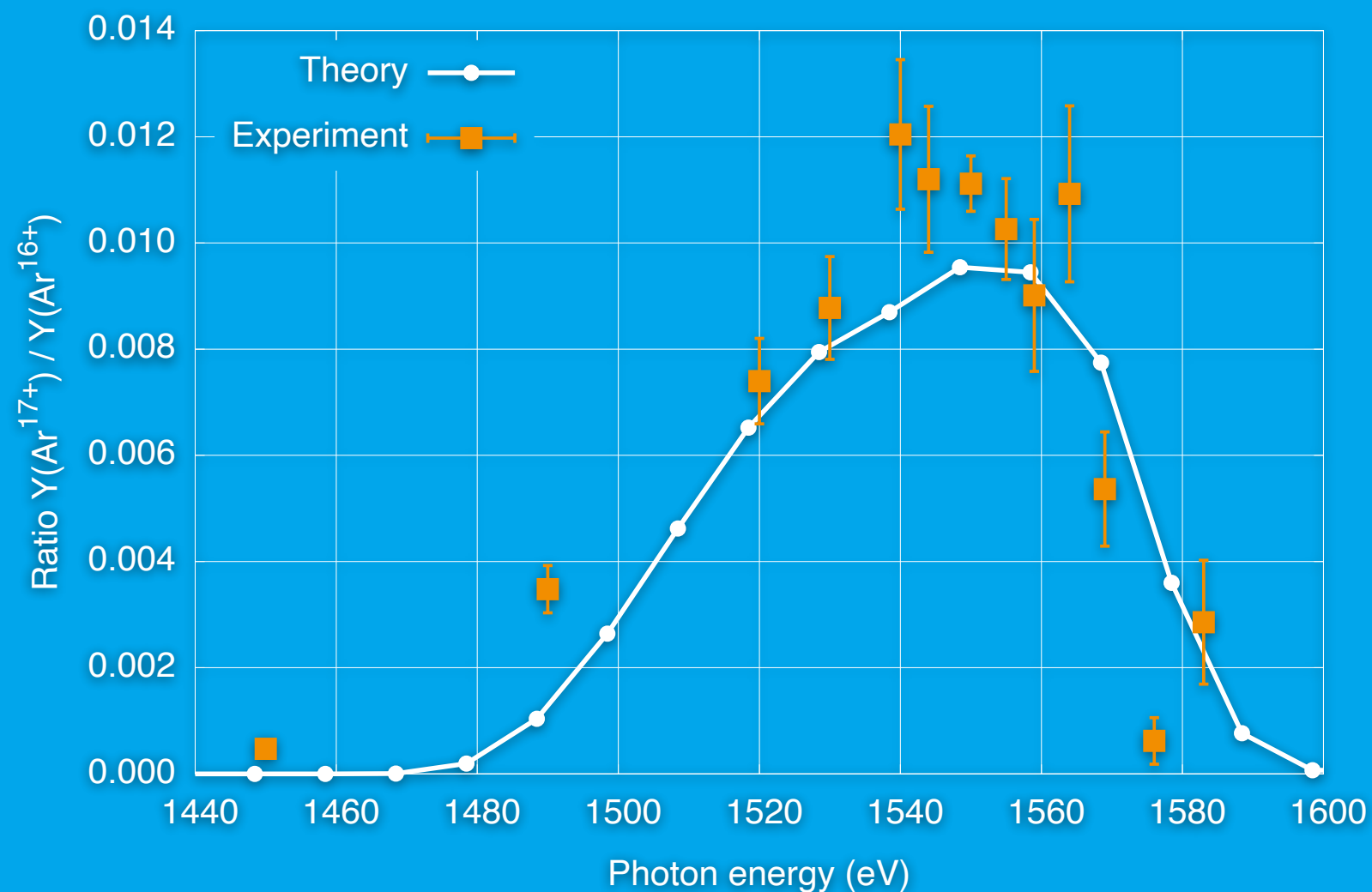
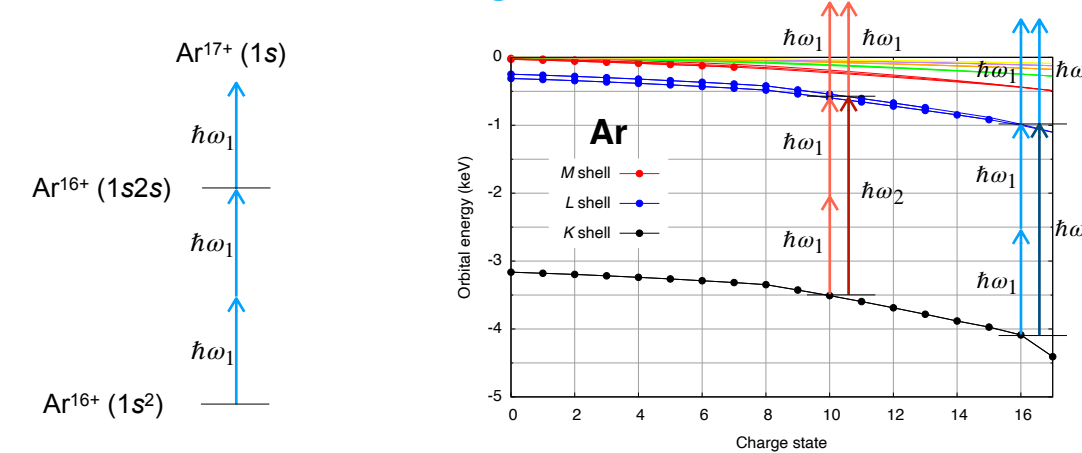


We first observed resonance-enhanced multiphoton ionization in the x-ray regime (XREMPI) using European XFEL.

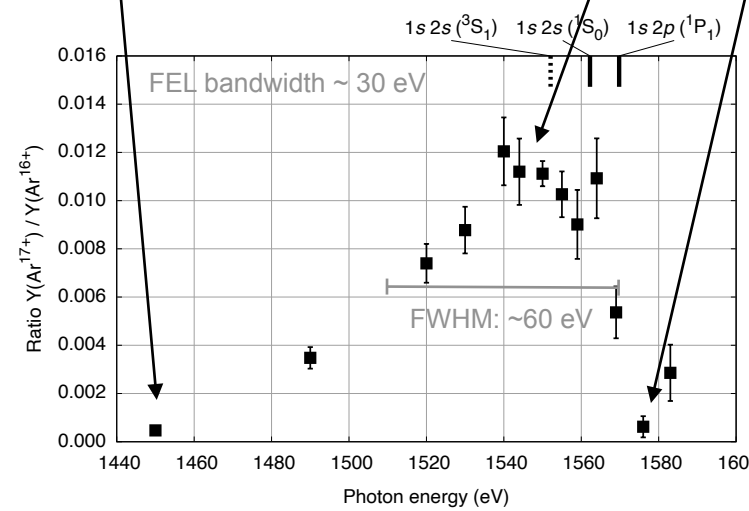
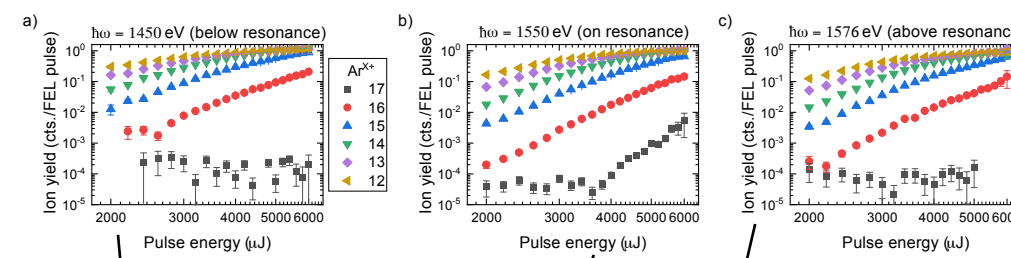


Ionization pathways



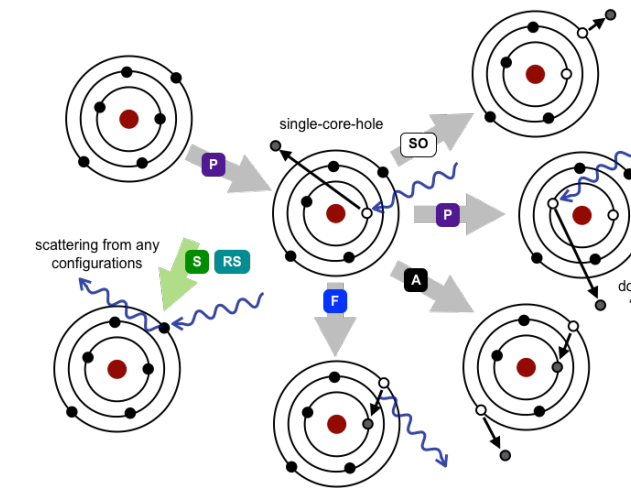
- IP of Ar¹⁶⁺ = 4130 eV
- Photon energy ~ 1550 eV
- Detection of Ar¹⁷⁺ → (2+1)-REMPI?
- Any other ionization pathways?
- Various ionization channels besides (2+1)-REMPI
- 2nd harmonic (0.2% contrib.) → (1'+1)-REMPI
- At low charges → (2+n)-REMPI or (1'+n)-REMPI

Experiment: European XFEL



- Small Quantum System (SQS) scientific instrument at the European XFEL
- Pulse length: 25 fs FWHM (nominal) / focal size: approx. 1.5x1.5 μm² (FWHM) / pulse energy: 2–6 mJ
- Photon energy: 1450–1583 eV / energy bandwidth: approx. 1% (FWHM) / second harmonic contrib.: est. 0.2–0.6%
- **Broad, red-shifted, asymmetric** resonance profile in stark contrast to the conventional REMPI

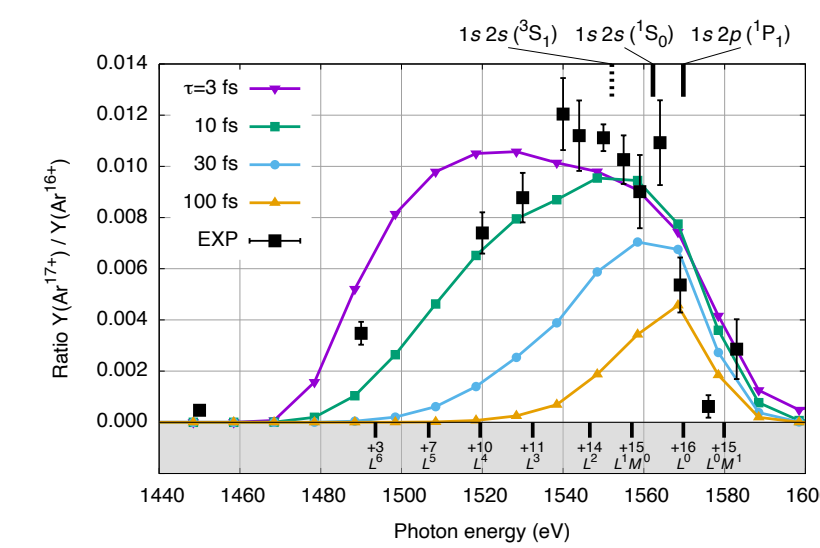
Theory: XATOM



- X-ray-induced atomic processes calculated for any given element and configuration
- Electronic structure based on the Hartree-Fock-Slater model
- Ionization dynamics solved by a rate-equation approach
- Sequential ionization model has been tested by a series of atomic XFEL experiments

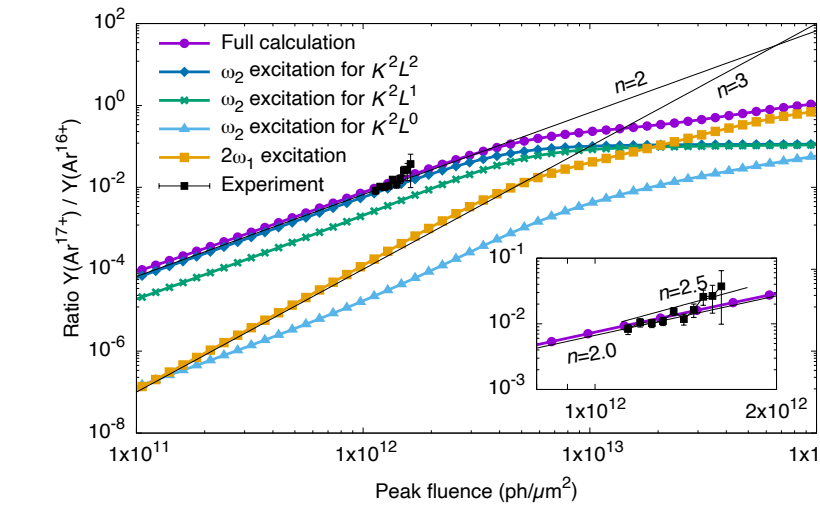
Son et al., *Phys. Rev. A* **83**, 033402 (2011).
 Jurek et al., *J. Appl. Cryst.* **49**, 1048 (2016).
 Download executables: <http://www.desy.de/~xraypac>

Comparison between theory and experiment



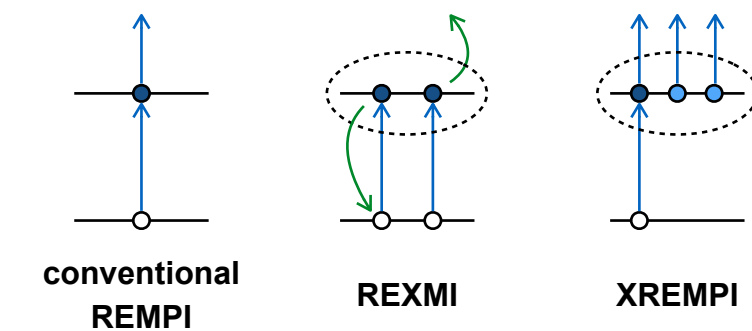
- Calculation with 10-fs matches well with experimental data.
- In experiment, the resonance profile looks all different from conventional REMPI.
- In theory, the profile is not only broadened but also shifted to lower energies as the pulse length gets shorter.
- The predicted pulse-length dependence cannot be explained by ordinary REMPI, because the same bandwidth is applied and AC Stark shift is negligible in the x-ray regime.
- It can be explained by the **various ionization pathways at lower charges** and associated decay lifetimes, rather than the bandwidth → potentially applicable to characterize FEL beam parameters.

Analyzing resonant processes



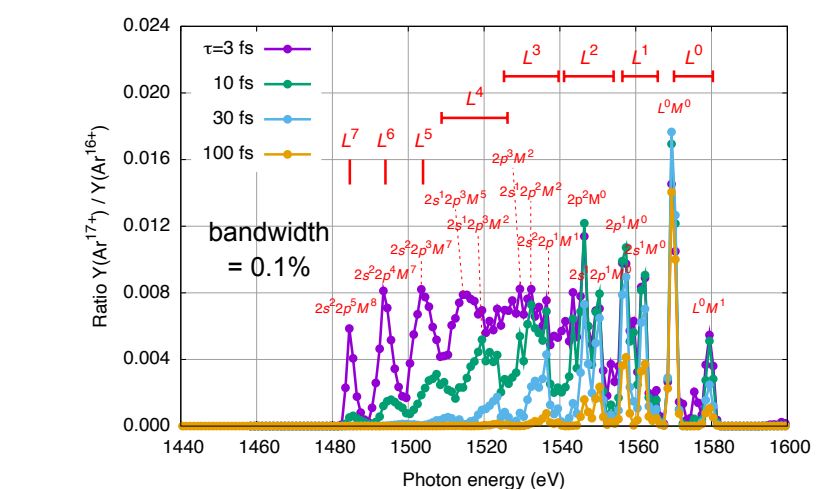
- Add and subtract processes in calculations
- (1'+3)-REMPI at Ar¹⁴⁺
- (1'+2)-REMPI at Ar¹⁵⁺
- (1'+1)-REMPI at Ar¹⁶⁺
- (2+n)-REMPI at all Q
- Dominant process: resonant excitation by 2nd harmonic at Ar¹⁴⁺ (more precisely, K²L²M^m for 0 ≤ m ≤ 8)

REMPI vs. REXMI vs. XREMPI

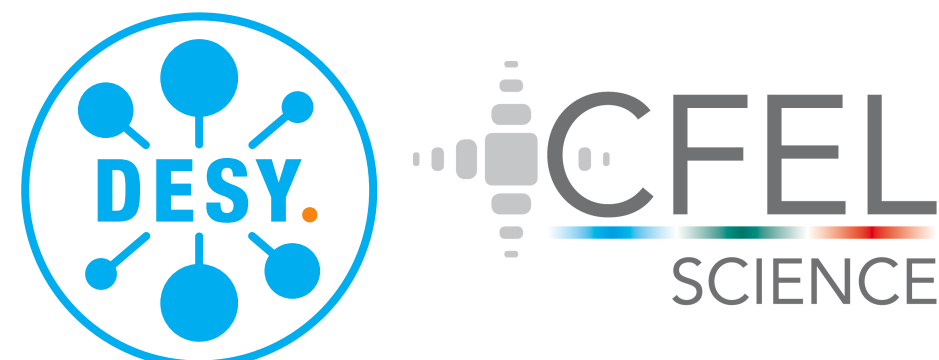


- **REXMI** (resonance-enabled or enhanced x-ray multiple ionization): multi-electron excitation involved; electron-correlation-driven relaxation; broad bandwidth favorable
 - **XREMPI**: single-electron excitation; narrow bandwidth favorable; not necessarily single ionization; influenced by ultrafast decay processes
- REXMI: Rudek et al., *Nat. Photon.* **6**, 858 (2012);
 Rudek et al., *Nat. Commun.* **9**, 4200 (2018).

Narrower FEL bandwidth



- SASE FEL bandwidth given by the shortest pulse length of spiky pulses, typically ~1%
- Narrower bandwidth through the use of a monochromator or self-seeding techniques
- With narrower bandwidth, individual resonance structures of electron config. could be resolved → potentially precision spectroscopy of highly charged ions of astrophysical relevance



Resonance-enhanced multiphoton ionization in the x-ray regime.

Sang-Kil Son*, Aaron C. LaForge, Debadarshini Mishra, Markus Ilchen, Stephen Duncanson, Eemeli Eronen, Edwin Kukk, Stanislaw Wirok-Stoletow, Daria Kolbasova, Peter Walter, Rebecca Boll, Alberto De Fanis, Michael Meyer, Yevheniy Ovcharenko, Daniel E. Rivas, Philipp Schmidt, Sergey Usenko, Robin Santra, Nora Berrah

A. C. LaForge et al.,
Phys. Rev. Lett. **127**,
 213202 (2021).

